Reliability Data Sheet



Stretched SO8/SO6 Mechanical and Environmental Testing

Description

The document's reliability data shown includes Broadcom[®] reliability test data from the reliability tests done on this product family. All of these products use similar processes and materials. The data in Table 1 and Table 2 reflect actual test data for the devices. Before stress, all devices are preconditioned at MSL 1 using a solder reflow process (260°C peak temperature) and 20 temperature cycles (–55°C to +125°C, 15 minutes dwell, 1 minute transfer). This data is taken from testing on Broadcom devices using internal Broadcom processes, material specifications, design standards, and statistical process controls.

This data is not transferable to other manufacturer's similar part types.

Definition of Failure

Abnormal resistance (meaning open or short failure) is the definition of failure in this data sheet. Specifically, failure occurs when the device fails contact resistance either high or low, or both, and/or when the device experiences abnormal leakages, or both.

Reliability Testing

Broadcom subjects the devices to a series of reliability tests (including environmental, mechanical, and electrical tests) to ensure they meet the intended reliability expectation. The following tables show the results of reliability testing conducted by Broadcom over a period of time (as shown in the test conditions).

Table 1: Mechanical Tests (Testing Done on a Constructional Basis)

| Test Name | Reference Standard | Test Conditions | Units Tested | Units Failed |
|-----------------------------------|-----------------------|---|-----------------|-----------------|
| Temperature Cycling' | JESD-A104 | -55°C to 125°C, Transfer = 1 minute, Dwell = 15 minutes, 1000 cycles | 5267 | 0 |
| Temperature Cycling | JESD-A104 | -65°C to 150°C, Transfer = 1 minute, Dwell = 15 minutes, 500 cycles | 596 | 0 |
| Solderability (RoHS condition) | JESD-B102 | 8 hours steam aging (93°C), followed by solder dip (260°C, 5 seconds) | 131 | 0 |
| Physical Dimensions | JESD-B100 | Conformance to data sheet package drawings | 20 | 0 |
| Preconditioning | JESD-020 JESD-A113 | As per reference standard (to conform to MSL 1) | 19,930 | 0 |

Table 2: Environmental Tests (Testing Done on a Constructional Basis)

| Test Name | Reference Standard | Test Conditions | Units Tested | Units Failed |
|---------------------------|-----------------------|--|-----------------|-----------------|
| Temperature-Humidity-Bias | JESD-A101 | T _A = 85°C, RH = 85%, Biased, Time = 1000 hours | 118 | 0 |
| HAST | JESD-A110 | T _A = 130°C, RH = 85%, Biased, Time = 96 hours | 3157 | 0 |
| Unbiased HAST | JESD-A118 | T _A = 130°C, RH = 85%, Unbiased, Time = 96 hours | 2349 | 0 |
| Autoclave | JESD-A102 | T _A = 121°C, RH = 100%. Unbiased, Time = 96 hours | 984 | 0 |
| High Temperature Bake | JESD-A103 | T _A = 150°C, Unbiased, Time = 1000 hours | 2830 | 0 |

Broadcom Stretched-SO8-SO6-RDS101

| Disclaimer |
|--|
| Broadcom reserves the right to modify the data and is correct at the time of release |
| |
| |
| |
| |
| |
| |
| |
| |
| |
| |
| |
| |
| Copyright © 2019-2022 Broadcom. All Rights Reserved. The term "Broadcom" refers to Broadcom Inc. and/or its subsidiaries. For more information, go to www.broadcom.com . All trademarks, trade names, service marks, and logos referenced herein belong to their respective companies. |
| Broadcom reserves the right to make changes without further notice to any products or data herein to improve reliability, function, or design. Information furnished by Broadcom is believed to be accurate and reliable. However, Broadcom does not assume any liability arising out of the application or use of this information, nor the application or use of any product or circuit described herein, neither does it convey any license under its patent rights nor the rights of others. |
| |
| |
| |
| |
| |
| ● BROADCOM® |